

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Examination
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Examiner

D. Ben Esplin

Art Unit

2851

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,363,171	11-1994	Mack, Chris A.	355/68
	B	US-5,581,324	12-1996	Miyai et al.	355/53
	C	US-5,721,608	02-1998	Taniguchi, Tetsuo	355/53
	D	US-6,002,467	12-1999	Nishi et al.	355/61
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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